

Contribution ID: 806 Contribution code: THPC45 Type: Poster Presentation

## EIC impedance and beam dynamics

Thursday, 23 May 2024 16:00 (2 hours)

A new high-luminosity Electron-Ion Collider (EIC) is being developed at BNL. Beam collisions occur at IP-6, involving two rings: the Electron Storage Ring (ESR) and the Hadron Storage Ring (HSR). The vacuum system of both rings is newly developed and impedance optimization is progressing. Beam-induced heating and thermal analysis are performed for both rings to manage and control thermal distribution. The study explores collective effects across the Rapid Cycling Synchrotron (RCS), ESR, and HSR using simulated single bunch wakefields. Discussions encompass impedance analysis, collective effects and beam interactions, and the impact of ion and electron clouds on beam dynamics.

## **Footnotes**

**Funding Agency** 

## Paper preparation format

LaTeX

## Region represented

North America

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Session Classification: Thursday Poster Session

**Track Classification:** MC5: Beam Dynamics and EM Fields: MC5.D04 Beam Coupling Impedance

Theory, Simulations, Measurements, Code Development